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Merjenje radioaktivnosti - Merjenje in vrednotenje površinske kontaminacije - 1. del: Splošna načela

Measurement of radioactivity - Measurement and evaluation of surface contamination - Part 1: General principles

iTeh Standards

Mesurage de la radioactivité — Mesurage et évaluation de la contamination de surface — Partie 1: Principes généraux

Ta slovenski standard je istoveten z: ISO 7503-1:2016

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Measurement of radioactivity — Measurement and evaluation of surface contamination —

Part 1: **General principles**

Mesurage de la radioactivité — Mesurage et évaluation de la contamination de surface —

Partie 1: Principes généraux

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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights. Details of any patent rights identified during the development of the document will be in the Introduction and/or on the ISO list of patent declarations received (see www.iso.org/patents).

Any trade name used in this document is information given for the convenience of users and does not constitute an endorsement.

For an explanation on the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the WTO principles in the Technical Barriers to Trade (TBT) see the following URL: Foreword - Supplementary information

The committee responsible for this document is ISO/TC 85, *Nuclear energy nuclear technologies and radiological protection*, Subcommittee SC 2, *Radiation protection*.

This second edition cancels and replaces the first edition (ISO 7503-1:1988), which has been technically revised.

ISO 7503 consists of the following parts, under the general title *Measurement of radioactivity* — *Measurement and evaluation of surface contamination*:

- Part 1: General principles
- Part 2: Test method using wipe-test samples
- Part 3: Apparatus calibration

This corrected version of ISO 7503-1:2016 incorporates the following corrections:

- In 3.2, for I(A), replace " $(Bq \cdot cm^{-2})/s^{-1}$ " by " $s^{-1}/(Bq \cdot cm^{-2})$ ";
- In Clause 9, replace the first paragraph which has been rephrased.

Introduction

ISO 7503 gives guidance on the measurement of surface contamination. This International Standard is applicable to many situations where radioactive contamination can occur. Contamination arises from the release of radioactivity into the local environment. In most circumstances, the release is inadvertent but, on occasion, may be deliberate. Although the purpose and scope of the investigation may differ, the approaches taken to measure the levels and extent of the contamination are essentially similar.

Radioactive contamination can arise from a number of activities or events such as the following:

- routine laboratory use of radio-chemicals;
- medical treatments;
- industrial applications;
- transport accidents;
- equipment malfunctions;
- malevolent incidents;
- nuclear accidents.

Without process knowledge or documentation, it is not always possible to identify or distinguish the different radionuclides constituting a surface contamination, and the evaluation of such a contamination cannot be made on a quantitative basis. Instead of using instruments with nuclide specific calibrations, it may be necessary to use other instruments which are fit for such a purpose.

However, there may be cases (e.g. a contaminated fuel material transport container) where the radionuclide or the radionuclide mixture can be clearly characterized. A surface contamination evaluation exceeding a pure qualitative assessment of fixed and removable surface contamination may then be needed. Moreover, following requirements laid down in national regulations and in international conventions, a measured surface contamination activity per unit area has to be compared with surface contamination guideline values or surface contamination limits.

Surface contamination guideline values are radionuclide-specific and thus require complex radionuclide-specific calibrations of measurement equipment. Calibration quality assurance is crucial in order to avoid non-detection (i.e. type II decision errors) leading to incorrectly assuming compliance with given surface contamination guideline values or limits. Evaluation of surfaces contaminated by a mixture of radionuclides with known ratios requires respectively proportionated calibration factors.

ISO 7503 is concerned with the measurement and estimation of radioactivity levels. It does not provide advice on decommissioning, planning and surveillance techniques.

Surface contamination is specified in terms of activity per unit area and the limits are based on the recommendations by the International Commission on Radiological Protection (ICRP 103).

This part of ISO 7503 deals with the evaluation of surface contamination by direct measurement using a surface contamination instrument, and in the case of the indirect method, using wipe tests. This part of ISO 7503 is primarily concerned with direct monitoring, practical guidance on measurements, it describes principles to keep an instrument in a fitness-for-purpose state. This part of ISO 7503 also presents instrument calibration principles and compiles the basic uncertainties of both surface contamination evaluation methods.

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Measurement of radioactivity — Measurement and evaluation of surface contamination —

Part 1:

General principles

1 Scope

ISO 7503 (all parts) and ISO 8769 are addressed to the people responsible for determining the radioactivity present on solid surfaces. ISO 7503 is published in three parts and can be used jointly or separately according to needs.

This part of ISO 7503 relates to the assessment of surface contamination by direct and indirect measurements and the calibration of the associated instrumentation.

The standard applies to alpha-, beta- and photon emitters and is intended for use by hospitals, universities, police, or industrial establishments. The standard also can be used in the assessment of activity on trucks, containers, parcels, equipment and is applicable in any organization which handles radioactive materials. Generally, it is applicable to well defined flat surfaces where direct methods are applicable, however, it can also be used for surfaces which are not flat and where indirect wipe tests would be appropriate. These investigations may be carried out on containers, inaccessible areas, non-flat areas where wipe tests can be used. This part of ISO 7503 may be useful in emergency situations, i.e. in nuclear accidents where health physics professionals would be involved.

This part of ISO 7503 does not apply to the evaluation of contamination of the skin, of clothing and of loose material such as gravel.

NOTE The test method using wipe-test samples for the evaluation of radioactive surface contaminations is dealt with in ISO 7503-2. The calibration of instruments for the evaluation of radioactive surface contaminations is dealt with in ISO 7503-3.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 8769, Reference sources — Calibration of surface contamination monitors — Alpha-, beta- and photon emitters

ISO 11929, Determination of the characteristic limits (decision threshold, detection limit, and limits of the confidence interval) for measurements of ionizing radiation — Fundamentals and application

ISO/IEC 17025, General requirements for the competence of testing and calibration laboratories

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3 Terms and definitions, symbols and abbreviations

3.1 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

3.1.1

activity per unit area

ratio between the activity of the radionuclides present on a surface and the area of that surface, expressed in becquerels per square centimetre

3.1.2

surface contamination

radioactive substances deposited on defined surfaces

3 1 3

fixed surface contamination

surface contamination which cannot be removed or transferred by non-destructive means

3.1.4

removable surface contamination

radioactive material that can be removed from surfaces by non-destructive means, including casual contact, wiping, or washing

Note 1 to entry: It should be noted that under the influence of moisture, chemicals, etc., or as a result of corrosion or diffusion, fixed contamination may become removable or *vice versa* without any human action. Furthermore, surface contaminations may decrease due to evaporation and volatilization.

Note 2 to entry: It should be emphasized that the ratio between fixed and removable contamination can vary over time, and that some decisions, such as those related to clearance, should be based on total activity with the potential to become removable over time, not just the amount that is removable at the time of a survey.

3.1.5

direct measurement of surface contamination

measurement of surface contamination by means of a contamination meter or monitor 0/sist-iso-7503-1-2025

3.1.6

indirect evaluation of surface contamination

evaluation of the removable surface contamination by means of a wipe test

3.1.7

wipe test

test to determine if removable contamination is present through wiping the surface with a dry or wet material, followed by evaluation of the wipe material for removable contamination

3.1.8

wiping efficiency

ratio of the activity of the radionuclides removed from the surface by one wipe sample to the activity of the radionuclides of the removable surface contamination prior to this sampling

Note 1 to entry: In practice, it is almost impossible to measure the total amount of removable activity on the surface, and in most cases, a value for the wiping efficiency cannot be assessed but can only be estimated.

3.1.9

surface emission rate of a source

number of particles of a given type above a given energy or of photons emerging from the front face of the source per unit time

3.1.10

instrument efficiency

ratio between the instrument net reading and the surface emission rate of a source under given geometrical conditions

3.1.11

emission instrument response

instrument efficiency times detector window area, equals the observed net count rate per surface emission rate per unit area of a calibration source

3.1.12

activity instrument response

instrument efficiency times detector window area times the probability of a particle or photon leaving the source surface, equals the observed net count rate per Bq per unit area of a calibration source

3.1.13

emission calibration factor

reciprocal of instrument efficiency times window area

3.1.14

activity calibration factor

reciprocal of instrument efficiency times window area times probability of a particle leaving the source surface

3.1.15

calibration

operation that, under specified conditions, in a first step, establishes a relation between the quantity values with measurement uncertainties provided by measurement standards and corresponding indications with associated measurement uncertainties and, in a second step, uses this information to establish a relation for obtaining a measurement result from an indication

3.1.16

guideline value

value which corresponds to scientific, legal or other requirements for which the measuring procedure is intended to assess log/standards/sist/c6b864dd-df19-41ce-99f5-204f6d67eb20/sist-iso-7503-1-2025

3.2 Symbols and abbreviated terms

For the purposes of this part of ISO 7503, the following symbols apply:

- I(E) emission instrument response in s⁻¹/(s⁻¹·cm⁻²)
- ρ_c observed count rate from the calibration source in s⁻¹
- ρ_0 background count rate in s⁻¹
- $R_{\rm c}$ emission rate of the calibration source in s⁻¹
- $S_{\rm c}$ area of the calibration source in cm²
- I(A) activity instrument response in s⁻¹/(Bq·cm⁻²)
- $A_{\rm c}$ activity of the calibration source in Bq
- *P* inverse of probability of a particle emerging from the surface, equal ratio of the particle or photon generation rate (activity) and the emission rate from the surface in Bq^{-1}/s^{-1}
- $S_{\rm p}$ effective detector or probe area in cm²
- C(E) emission calibration factor in $(s^{-1} \cdot cm^{-2})/s^{-1}$